

XPIN®-BT x-ray detector



XPIN®-BT

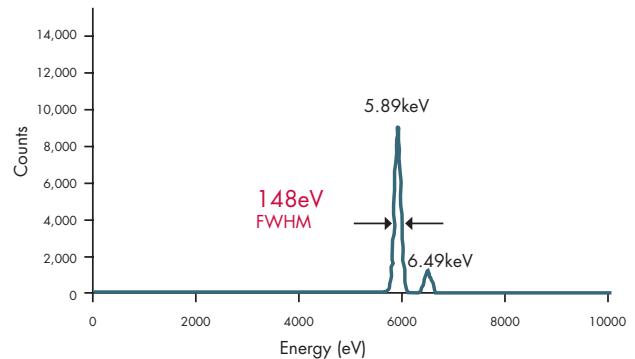
Applications

- Portable/ Benchtop XRF
- RoHS/WEEE
- Light element analysis
- Metallurgy
- Alloy sorting
- Scientific research
- Nuclear monitoring
- Quality control
- Brand protection
- Coating analysis
- Plastic additive analysis
- Soil analysis
- OSHA compliance
- Contamination sampling
- Archeology
- Art authentication
- Forensic
- Mobile crime labs

Features	Benefits
Si-PIN diode	Low cost
Small, compact design	Close coupling between detector and source, portable
Two-stage thermoelectric cooler	Fast cooling without liquid nitrogen
Stable resolution	Minimal calibration maintenance
Thin DuraBeryllium® windows	Light-element identification, corrosion resistant
Wide ambient temperature range	Industrial applications
Multi-layer collimator	Minimal stray peaks
Internal temperature control	No external temperature control required

The XPIN® detector is Moxtek's best performing Si-PIN detector. XPIN detectors use a silicon PIN diode, multi-layer collimator, and thin DuraBeryllium® window, achieving great resolution and x-ray sensitivity. The XPIN preamp provides a low-noise signal output to an analog or digital pulse shaping amplifier. The XPIN-BT package is ideal for benchtop and portable applications requiring simple mounting, automatic temperature control, and metal shielding.

Example XPIN Spectrum (6mm²)
Fe⁵⁵, 5.89keV @ -55°C, 8μs Shaping Time



Example XPIN Spectrum (13mm²)
Fe⁵⁵, 5.89keV @ -55°C, 8μs Shaping Time

